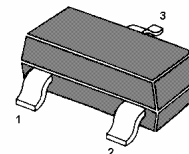
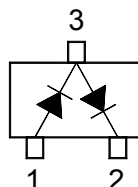


HIGH-SPEED DOUBLE DIODE

fast switching in thick and thin-film circuits diode



SOT-23 Plastic Package

Absolute Maximum Ratings ($T_a = 25\text{ }^{\circ}\text{C}$)

Parameter	Symbol	Value	Unit
Repetitive Peak Reverse Voltage	V_{RRM}	85	V
Continuous Reverse Voltage	V_R	75	V
Continuous Forward Current (Double Diode Loaded)	I_F	125	mA
Continuous Forward Current (Single Diode Loaded)	I_F	215	mA
Repetitive Peak Forward Current	I_{FRM}	450	mA
Non-repetitive Peak Forward Current $T_j = 25\text{ }^{\circ}\text{C}$ at $t = 1\text{ }\mu\text{s}$ at $t = 1\text{ ms}$ at $t = 1\text{ s}$	I_{FSM}	4 1 0.5	A
Power Dissipation	P_{tot}	250	mW
Junction Temperature	T_j	150	$^{\circ}\text{C}$
Storage Temperature Range	T_s	- 65 to + 150	$^{\circ}\text{C}$

Characteristics at $T_a = 25\text{ }^{\circ}\text{C}$

Parameter	Symbol	Max.	Unit
Forward Voltage at $I_F = 1\text{ mA}$ at $I_F = 10\text{ mA}$ at $I_F = 50\text{ mA}$ at $I_F = 150\text{ mA}$	V_F	0.715 0.855 1 1.25	V
Reverse Current at $V_R = 25\text{ V}$ at $V_R = 75\text{ V}$ at $V_R = 25\text{ V}$, $T_j = 150\text{ }^{\circ}\text{C}$ at $V_R = 75\text{ V}$, $T_j = 150\text{ }^{\circ}\text{C}$	I_R	30 1 30 50	nA μA μA μA
Diode Capacitance at $f = 1\text{ MHz}$	C_d	1.5	pF
Reverse Recovery Time at $I_F = I_R = 10\text{ mA}$, $I_R = 1\text{ mA}$, $R_L = 100\text{ }\Omega$	t_{rr}	4	ns
Forward Recovery Voltage at $I_F = 10\text{ mA}$, $t_r = 20\text{ ns}$	V_{fr}	1.75	V
Thermal Resistance from Junction to ambient ¹⁾	R_{thja}	500	K/W

¹⁾ Device mounted on an FR4 printed-circuit board.

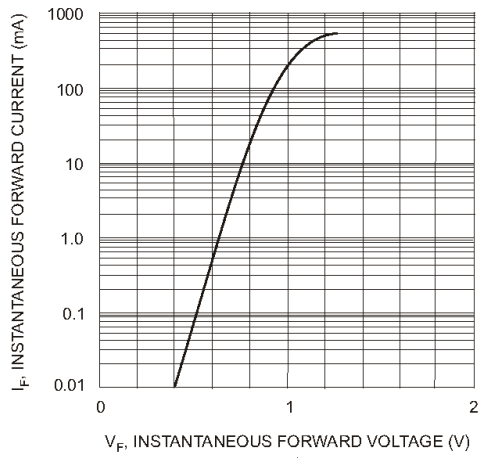


Fig. 1 Forward Characteristics

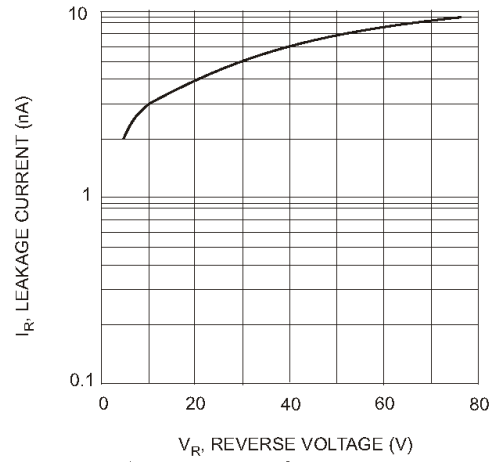


Fig. 2 Typical Leakage Current vs Reverse Voltage

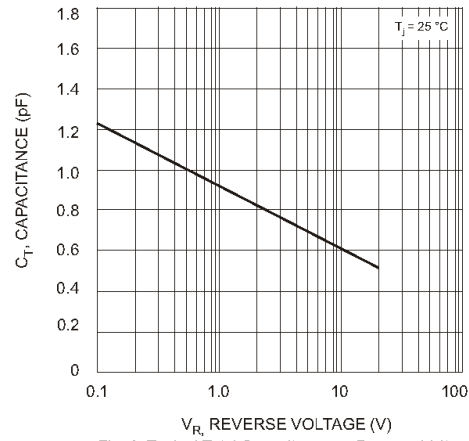


Fig. 3 Typical Total Capacitance vs Reverse Voltage